Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/784,994	FUJIBAYASHI, AKIRA	
Examiner	Art Unit	
Patrick M. Moore	2188	

SEARCHED					
Class	Subclass	Date	Examiner		
		-			

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
	L				

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Updated Classification and Text Searches to discover newly published matter since previous searching	7/20/2006	РММ		
Interference Search [see: S94-S96]	7/20/2006	РММ		
Discussed Applicant's arguments and state of prior art with Primary Examiner [Gary Portka]	7/19/2006	РММ		